

Surface chemical analysis — X-ray photoelectron spectroscopy — Description of selected instrumental performance parameters

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National foreword

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The UK participation in its preparation was entrusted to Technical Committee CII/60, Surface chemical analysis, which has the responsibility to:

- aid enquirers to understand the text;
- present to the responsible international/European committee any enquiries on the interpretation, or proposals for change, and keep the UK interests informed;
- monitor related international and European developments and promulgate them in the UK.

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Summary of pages

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Surface chemical analysis — X-ray photoelectron spectroscopy — Description of selected instrumental performance parameters

*Analyse chimique des surfaces — Spectroscopie de
photoélectrons X — Description de certains paramètres relatifs à
la performance instrumentale*



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